


<b>Search Notes</b>  	<b>Application/Control No.</b>  10565304	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  William C Doerrler	<b>Art Unit</b>  3744

SEARCHED			
Class	Subclass	Date	Examiner
62	6	4-2-2008	WCD
165	104.21	4-2-2008	WCD

SEARCH NOTES		
Search Notes	Date	Examiner
See Report (EAST)	4-2-2008	WCD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
See Report		9-16-2008	WCD

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